V-Ex-1-09-E-Scan-24

(Librony) Elective II: VISI Design,

Con. 3006-09.

25/5/09

VR-4179

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(REVISED COURSE)

(3 Hours)

[Total Marks: 100

- N.B: (1) Question No.1 is Compulsory.
 - (2) Attempt any four out of remaining six questions.
 - (3) Assume suitable data wherever necessary.
- 1. (a) Explain various sources of power dissipation in digital CMOS circuits and explain 10 the methods to reduce power dissipation.
 - Discuss in detail 4 x 4 array multiplier. Can this be used as a building block to create 10 (b) an 8 x 8 multiplier? If so detail the problems and modifications that need to be made.
- Explain the different types of physical fault that can occur in a CMOS chip and (a) 10 2. relate them to a typical circuit failure.
 - Explain EEPROM using floating gate NMOSFETS. (b)
- Summarize the approach you would take to reduce the power dissipation of a CMOS 10 3. (a) chip that is designed for palm top computer.
 - What would be the conductor width of power and ground wires to a 50 MHz clock (b) 10 buffer that drives 100pF of on-chip load to satisfy the metal migration consideration $(J_{AI} = 0.5 \text{ mA}/\mu)$? What is the ground bounce with the chosen Conductor size. The module is 500 µm from both the power and the ground Pads and the supply voltage is 5 volts. The rise/fall time of the clock is 1 nsec.(Assume $R_s = .05 \Omega/sq$).
- 4. (a) Construct a circuit diagram for a CMOS logic gate that implements the AOI function 10 F = A [B + C (D + E)] Design the W/L ratio for the transistors.
 - Design CMOS implementation of JK flip flop. Explain what are the limitations 10 (b) of your design.

5.	 (a) (b) (a) (b) 	Discuss floor planning and routing in VLSI.Explain in detail Pipelined system design.Explain three main approaches to Design for Testability in detail.What is cross talk in integrated circuits ? Discuss various methods to reduce it.	10 10 10 10
6.			

- 7. Write short notes on any three :---
 - (a) Behavioral and RTL modeling
 - (b) Low power design considerations
 - (c) Clock generation and Distribution
 - (d) Carry Look ahead adders.

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